

Cambridge University Press

978-1-107-41336-8 - Materials Research Society Symposium Proceedings: Volume 588:

Optical Microstructural Characterization of Semiconductors

Editors: M. Selim Ünlü, Javier Piqueras, Nader M. Kalkhoran and Takashi Sekiguchi

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**MATERIALS RESEARCH SOCIETY
SYMPOSIUM PROCEEDINGS VOLUME 588**

Optical Microstructural Characterization of Semiconductors

Symposium held November 29–30, 1999, Boston, Massachusetts, U.S.A.

EDITORS:

M. Selim Ünlü

Boston University
Boston, Massachusetts, U.S.A.

Javier Piqueras

Universidad Complutense de Madrid
Madrid, Spain

Nader M. Kalkhoran

Spire Corporation
Bedford, Massachusetts, U.S.A.

Takashi Sekiguchi

Tohoku University
Sendai, Japan



Materials Research Society
Warrendale, Pennsylvania

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CAMBRIDGE UNIVERSITY PRESS

Cambridge, New York, Melbourne, Madrid, Cape Town,
Singapore, São Paulo, Delhi, Mexico City

Cambridge University Press

32 Avenue of the Americas, New York NY 10013-2473, USA

Published in the United States of America by Cambridge University Press, New York

www.cambridge.org

Information on this title: www.cambridge.org/9781107413368

Materials Research Society

506 Keystone Drive, Warrendale, PA 15086

<http://www.mrs.org>

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First published 2000

First paperback edition 2013

Single article reprints from this publication are available through
University Microfilms Inc., 300 North Zeeb Road, Ann Arbor, MI 48106

CODEN: MRSPDH

ISBN 978-1-107-41336-8 Paperback

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